

**Issue Classification**

Devin Hanan 3/17/2006  
(Assistant Examiner) (Date)

Edward K Look 3/27/06  
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<b>Total Claims Allowed: 12</b>	
O.G. Print Claim(s)	O.G. Print Fig.
<b>1</b>	<b>1</b>

☐ Claims renumbered in the same order as presented by applicant

☐ CPA      ☐ T.D.      ☐ R.1.47